11 February 2021

Product data sheet

1. General description

Dual, Logic level N-channel MOSFET in an LFPAK56D package, using Trench 9 TrenchMOS technology. This product has been designed and qualified to AEC-Q101 for use in high performance automotive applications

2. Features and benefits

- Fully automotive qualified to AEC-Q101 at 175 °C
- Trench 9 superjunction technology:
 - · Low power losses, high power density
- · LFPAK copper clip package technology:
 - · High robustness and reliability
 - · Gull wing leads for high manufacturability and AOI
- Repetitive avalanche rated

3. Applications

- 12 V, 24 V and 48 V automotive systems
- · Motors, lamps and solenoid control
- Transmission control
- DC-to-DC conversion

4. Quick reference data

Table 1. Quick reference data

| Symbol | Parameter | Conditions | | Min | Тур | Max | Unit |
|-------------------|----------------------------------|--|-----|-----|------|----------|------|
| V _{DS} | drain-source voltage | 25 °C ≤ T _j ≤ 175 °C | | - | - | 40 | V |
| I _D | drain current | V _{GS} = 10 V; T _{mb} = 25 °C; <u>Fig. 2</u> | [1] | - | - | 42 | Α |
| P _{tot} | total power dissipation | T _{mb} = 25 °C; <u>Fig. 1</u> | | - | - | 46 | W |
| Static chara | cteristics FET1 and FET2 | | • | | | | |
| R _{DSon} | drain-source on-state resistance | V_{GS} = 4.5 V; I_D = 10 A; T_j = 25 °C; Fig. 11 | | 9.8 | 14.1 | 16.9 | mΩ |
| Dynamic ch | aracteristics FET1 and FE | T2 | | | ' | | ' |
| Q_{GD} | gate-drain charge | I _D = 10 A; V _{DS} = 32 V; V _{GS} = 5 V; T _j = 25 °C; <u>Fig. 13</u> ; <u>Fig. 14</u> | | - | 1.8 | 4.2 | nC |
| Source-drain | n diode FET1 and FET2 | | | | · | <u> </u> | |
| Q _r | recovered charge | I_S = 10 A; dI_S/dt = -100 A/ μ s; V_{GS} = 0 V; V_{DS} = 20 V; T_j = 25 °C | [2] | - | 16.2 | - | nC |

^{[1] 42}A continuous current has been successfully demonstrated during application tests. Practically the current will be limited by PCB, thermal design and operating temperature.



^[2] Includes capacitive recovery

Dual N-channel 40 V, 13 mOhm logic level MOSFET in LFPAK56D

5. Pinning information

Table 2. Pinning information

| Pin | Symbol | Description | Simplified outline | Graphic symbol |
|-----|--------|-------------|--|----------------|
| 1 | S1 | source1 | 8 7 6 5 | D1 D1 D2 D2 |
| 2 | G1 | gate1 | \(\frac{1}{2} \\ \frac{1}{2} \\ \fra | |
| 3 | S2 | source2 | | |
| 4 | G2 | gate2 | | |
| 5 | D2 | drain2 | | |
| 6 | D2 | drain2 | | S1 G1 S2 G2 |
| 7 | D1 | drain1 | 1 2 3 4 | mbk725 |
| 8 | D1 | drain1 | LFPAK56D; Dual LFPAK (SOT1205) | |

6. Ordering information

Table 3. Ordering information

| Type number | Package | | | | | |
|-------------|-------------------------|---|---------|--|--|--|
| | Name | Description | Version | | | |
| BUK9K13-40H | LFPAK56D; Dual LFPAK | plastic, single ended surface mounted package (LFPAK56D); 8 leads | SOT1205 | | | |

7. Marking

Table 4. Marking codes

| Type number | Marking code |
|-------------|--------------|
| BUK9K13-40H | 91340HK |

8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol | Parameter | Conditions | | Min | Max | Unit |
|------------------|-------------------------|---|-----|-----|-----|------|
| V _{DS} | drain-source voltage | 25 °C ≤ T _j ≤ 175 °C | | - | 40 | V |
| V_{GS} | gate-source voltage | DC; T _j = 25 °C | | -20 | 20 | V |
| P _{tot} | total power dissipation | T _{mb} = 25 °C; <u>Fig. 1</u> | | - | 46 | W |
| I _D | drain current | V _{GS} = 10 V; T _{mb} = 25 °C; <u>Fig. 2</u> | [1] | - | 42 | А |
| | | V _{GS} = 10 V; T _{mb} = 100 °C; <u>Fig. 2</u> | | - | 30 | А |
| I _{DM} | peak drain current | pulsed; $t_p \le 10 \mu s$; $T_{mb} = 25 °C$; Fig. 3 | | - | 169 | А |
| T _{stg} | storage temperature | | | -55 | 175 | °C |
| Tj | junction temperature | | | -55 | 175 | °C |
| Source-drain | liode FET1 and FET2 | | · | | | |
| Is | source current | T _{mb} = 25 °C | | - | 42 | А |
| I _{SM} | peak source current | pulsed; $t_p \le 10 \mu s$; $T_{mb} = 25 \text{ °C}$ | | - | 169 | А |

| Symbol | Parameter | Conditions | | Min | Max | Unit |
|----------------------|--|---|---------|-----|------|------|
| Avalanche Rugo | gedness FET1 and FET2 | | | | | |
| E _{DS(AL)S} | non-repetitive drain- source avalanche energy | I_D = 39.9 A; $V_{sup} \le 40$ V; R_{GS} = 50 Ω; V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; Fig. 4 | [2] [3] | - | 10.6 | mJ |
| I _{AS} | non-repetitive avalanche current | V_{sup} = 40 V; V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; R_{GS} = 50 Ω ; $Fig. 4$ | [4] | - | 39.9 | А |

- [1] 42A continuous current has been successfully demonstrated during application tests. Practically the current will be limited by PCB, thermal design and operating temperature.
- [2] Single-pulse avalanche rating limited by maximum junction temperature of 175 °C.
- [3] Refer to application note AN10273 for further information.
- [4] Protected by 100% test

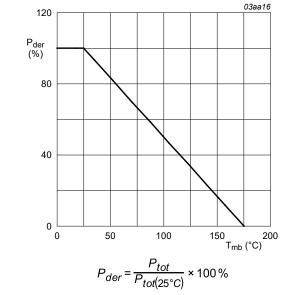
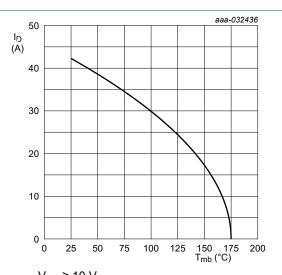
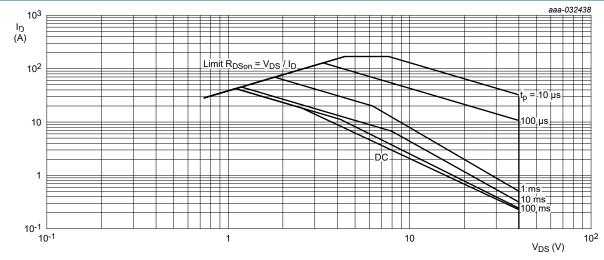


Fig. 1. Normalized total power dissipation as a function of mounting base temperature



 $V_{\rm GS} \ge 10~V$ 42A continuous current has been successfully demonstrated during application tests. Practically the current will be limited by PCB, thermal design and operating temperature.

Fig. 2. Continuous drain current as a function of mounting base temperature, FET1 and FET2

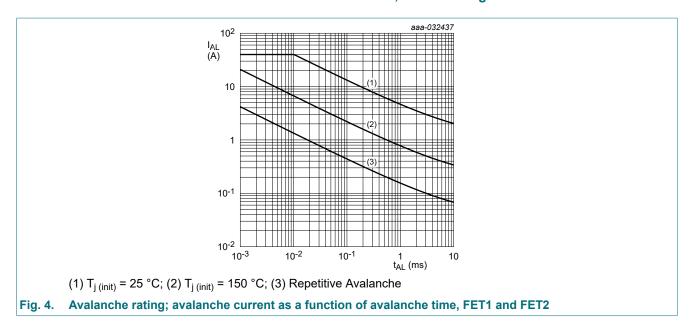


 T_{mb} = 25 °C; I_{DM} is single pulse

Fig. 3. Safe operating area; continuous and peak drain current as a function of drain-source voltage, FET1 and FET2

BUK9K13-40H

Dual N-channel 40 V, 13 mOhm logic level MOSFET in LFPAK56D



9. Thermal characteristics

Table 6. Thermal characteristics

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|----------------|---|---------------|-----|-----|------|------|
| $R_{th(j-mb)}$ | thermal resistance from junction to mounting base | <u>Fig. 5</u> | - | 3 | 3.23 | K/W |

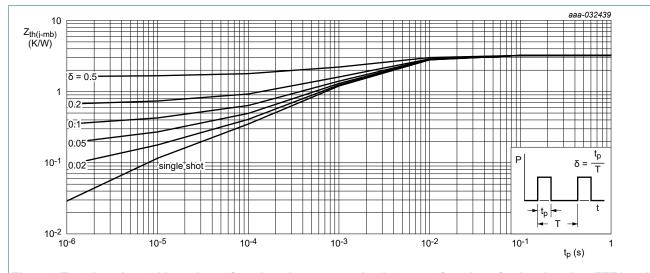


Fig. 5. Transient thermal impedance from junction to mounting base as a function of pulse duration, FET1 and FET2

Dual N-channel 40 V, 13 mOhm logic level MOSFET in LFPAK56D

10. Characteristics

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|-----------------------------------|----------------------------------|---|------|------|------|------|
| | acteristics FET1 and FET2 | | | | | |
| V _{(BR)DSS} drain-source | | I _D = 250 μA; V _{GS} = 0 V; T _i = 25 °C | 40 | 43 | - | V |
| (BIT)BOO | breakdown voltage | I _D = 250 μA; V _{GS} = 0 V; T _j = -40 °C | - | 40.5 | - | V |
| | | I _D = 250 μA; V _{GS} = 0 V; T _i = -55 °C | 36 | 40 | - | V |
| V _{GS(th)} | gate-source threshold voltage | I _D = 1 mA; V _{DS} =V _{GS} ; T _j = 25 °C; <u>Fig. 9</u> ; <u>Fig. 10</u> | 1.5 | 1.85 | 2.2 | V |
| | | I _D = 1 mA; V _{DS} =V _{GS} ; T _j = 175 °C; Fig. 10 | 0.7 | - | - | V |
| | | I _D = 1 mA; V _{DS} =V _{GS} ; T _j = -55 °C; <u>Fig. 10</u> | - | - | 2.6 | V |
| DSS | drain leakage current | V _{DS} = 40 V; V _{GS} = 0 V; T _j = 25 °C | - | 0.01 | 5 | μA |
| | | V _{DS} = 16 V; V _{GS} = 0 V; T _i = 125 °C | - | 0.14 | 10 | μA |
| | | V _{DS} = 40 V; V _{GS} = 0 V; T _i = 175 °C | - | 26 | 500 | μA |
| I _{GSS} | gate leakage current | V _{GS} = -10 V; V _{DS} = 0 V; T _i = 25 °C | - | 2 | 100 | nA |
| | | V _{GS} = 16 V; V _{DS} = 0 V; T _i = 25 °C | - | 2 | 100 | nA |
| R _{DSon} | drain-source on-state resistance | V _{GS} = 10 V; I _D = 10 A; T _j = 25 °C; Fig. 11 | 7.9 | 11.4 | 13.6 | mΩ |
| | | V _{GS} = 10 V; I _D = 10 A; T _j = 105 °C; Fig. 12 | 10.9 | 16 | 20.4 | mΩ |
| | | $V_{GS} = 10 \text{ V}; I_D = 10 \text{ A}; T_j = 125 ^{\circ}\text{C};$ Fig. 12 | 12 | 17.4 | 21.9 | mΩ |
| | | V _{GS} = 10 V; I _D = 10 A; T _j = 175 °C; Fig. 12 | 14.5 | 20.9 | 26.4 | mΩ |
| | | V _{GS} = 4.5 V; I _D = 10 A; T _j = 25 °C; Fig. 11 | 9.8 | 14.1 | 16.9 | mΩ |
| | | $V_{GS} = 4.5 \text{ V}; I_D = 10 \text{ A}; T_j = 105 ^{\circ}\text{C};$ Fig. 12 | 13.5 | 20 | 25.4 | mΩ |
| | | V _{GS} = 4.5 V; I _D = 10 A; T _j = 125 °C; Fig. 12 | 14.8 | 21.6 | 27.2 | mΩ |
| | | V _{GS} = 4.5 V; I _D = 10 A; T _j = 175 °C; Fig. 12 | 18 | 26.6 | 32.8 | mΩ |
| R_{G} | gate resistance | f = 1 MHz; T _j = 25 °C | 0.7 | 1.8 | 4.2 | Ω |
| Dynamic ch | naracteristics FET1 and FE | T2 | · | | | |
| Q _{G(tot)} | total gate charge | I _D = 10 A; V _{DS} = 32 V; V _{GS} = 10 V; T _j = 25 °C; <u>Fig. 13</u> ; <u>Fig. 14</u> | - | 13 | 19.4 | nC |
| | | I _D = 10 A; V _{DS} = 32 V; V _{GS} = 5 V; | - | 6.8 | 10.2 | nC |
| Q _{GS} | gate-source charge | T _j = 25 °C; <u>Fig. 13</u> ; <u>Fig. 14</u> | - | 2.3 | 3.8 | nC |
| Q _{GD} | gate-drain charge | | - | 1.8 | 4.2 | nC |
| C _{iss} | input capacitance | V _{DS} = 25 V; V _{GS} = 0 V; f = 1 MHz; | - | 848 | 1160 | pF |
| Coss | output capacitance | T _j = 25 °C; <u>Fig. 15</u> | - | 280 | 420 | pF |
| C _{rss} | reverse transfer capacitance | | - | 39 | 84 | pF |
| d(on) | turn-on delay time | $V_{DS} = 32 \text{ V}; R_L = 3.2 \Omega; V_{GS} = 5 \text{ V};$ | - | 6.5 | - | ns |
| t _r | rise time | $R_{G(ext)} = 5 \Omega; T_j = 25 °C$ | - | 9.7 | - | ns |
| t _{d(off)} | turn-off delay time | 1 | - | 10.1 | - | ns |

| Symbol | Parameter | Conditions | | Min | Тур | Max | Unit |
|----------------------------------|-----------------------|--|-----|-----|------|-----|------|
| t _f | fall time | | | - | 7.8 | - | ns |
| Source-drain diode FET1 and FET2 | | | | | | | |
| V_{SD} | source-drain voltage | $I_S = 10 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 25 ^{\circ}\text{C}; Fig. 16$ | | - | 0.81 | 1 | V |
| t _{rr} | reverse recovery time | $I_S = 10 \text{ A}$; $dI_S/dt = -100 \text{ A/}\mu\text{s}$; $V_{GS} = 0 \text{ V}$; | | - | 21.5 | - | ns |
| Q _r | recovered charge | $V_{DS} = 20 \text{ V}; T_j = 25 \text{ °C}$ | [1] | - | 16.2 | - | nC |

[1] Includes capacitive recovery

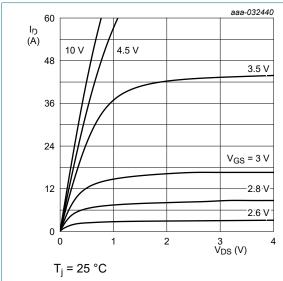
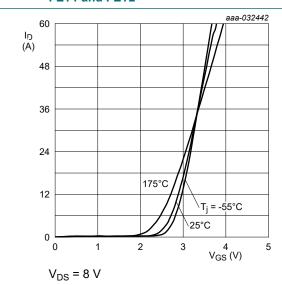


Fig. 6. Output characteristics; drain current as a function of drain-source voltage; typical values, **FET1 and FET2**



Transfer characteristics; drain current as a Fig. 8. function of gate-source voltage; typical values, **FET1 and FET2**

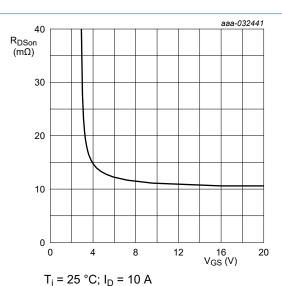
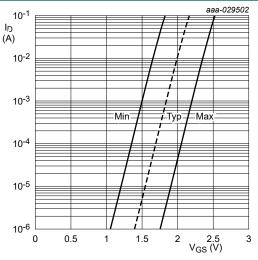


Fig. 7. Drain-source on-state resistance as a function of gate-source voltage; typical values. FET1 and FET2



 $T_i = 25 \,^{\circ}C; V_{DS} = 5 \,^{\circ}V$

Sub-threshold drain current as a function of Fig. 9. gate-source voltage, FET1 and FET2

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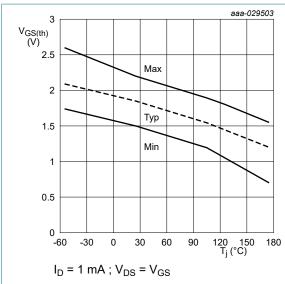


Fig. 10. Gate-source threshold voltage as a function of junction temperature, FET1 and FET2

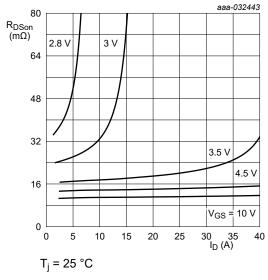


Fig. 11. Drain-source on-state resistance as a function of drain current; typical values, FET1 and FET2

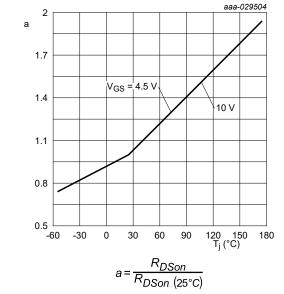


Fig. 12. Normalized drain-source on-state resistance factor as a function of junction temperature, FET1 and FET2

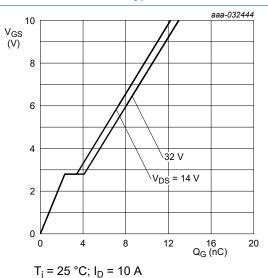


Fig. 13. Gate-source voltage as a function of gate charge; typical values, FET1 and FET2

Dual N-channel 40 V, 13 mOhm logic level MOSFET in LFPAK56D

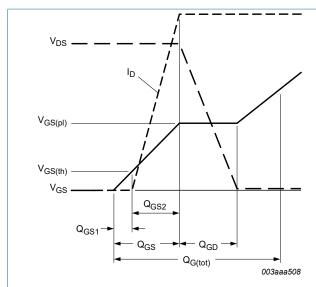
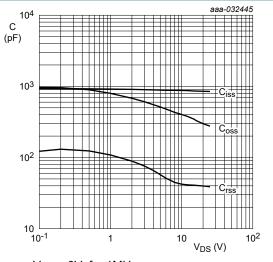
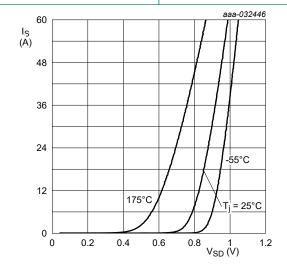


Fig. 14. Gate charge waveform definitions



 $V_{GS} = 0V$; f = 1MHz

Fig. 15. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values, FET1 and FET2



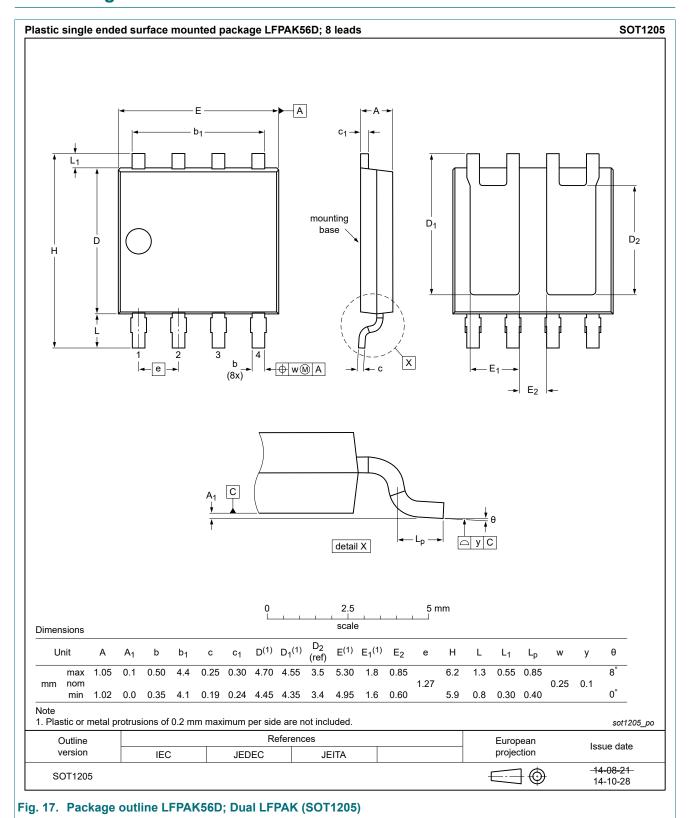
 $V_{GS} = 0 V$

Fig. 16. Source-drain (diode forward) current as a function of source-drain (diode forward) voltage; typical values FET1 and FET2

Product data sheet

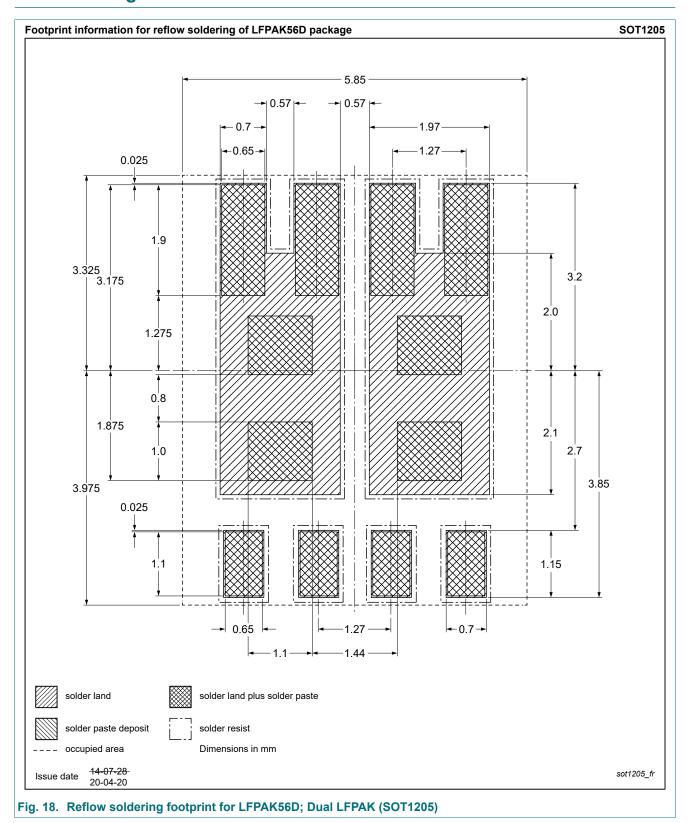
Dual N-channel 40 V, 13 mOhm logic level MOSFET in LFPAK56D

11. Package outline



Dual N-channel 40 V, 13 mOhm logic level MOSFET in LFPAK56D

12. Soldering



BUK9K13-40H

13. Legal information

Data sheet status

| Document status [1][2] | Product status [3] | Definition |
|--------------------------------|-----------------------|---|
| Objective [short] data sheet | Development | This document contains data from the objective specification for product development. |
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